

Notice of References Cited	Application/Control No. 10/085,742	Applicant(s)/Patent Under Reexamination YAMANOI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,262,957 B1	07-2001	Inoue et al.	369/53.23
	B	US-6,249,494 B1	06-2001	Ueki, Yasuhiro	369/44.27
	C	US-6,288,987 B1	09-2001	Kumagai, Eiji	369/44.29
	D	US-6,487,153 B2	11-2002	Kamiyama et al.	369/53.23
	E	US-6,278,672 B1	08-2001	Kobayashi, Yoshihiro	369/53.23
	F	US-6,747,931 B1	06-2004	Park, Sang-On	369/53.23
	G	US-6,603,720 B1	08-2003	Kuroda et al.	369/53.23
	H	US-6,822,936 B2	11-2004	Ono et al.	369/53.23
	I	US-6,466,531 B1	10-2002	Lee, Jae-Hong	369/53.2
	J	US-4,572,965	02-1986	Yamamura, Shinichi	307/130
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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